

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

## TC74LCX374F, TC74LCX374FW, TC74LCX374FT

### Low-Voltage Octal D-Type Flip-Flop with 5-V Tolerant Inputs and Outputs

The TC74LCX374F/FW/FT is a high-performance CMOS octal D-type flip-flop. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

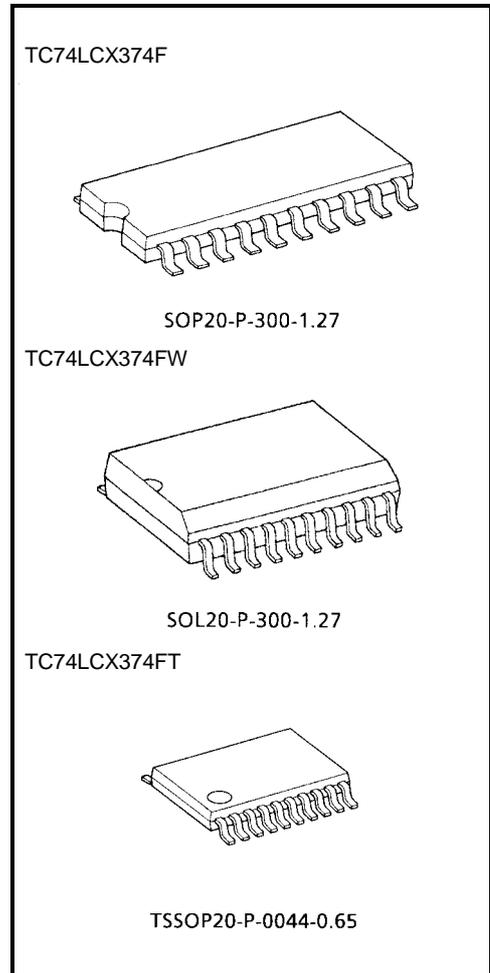
This 8 bit D-type flip-flop is controlled by a clock input (CK) and a output enable input (OE). When the OE input is high, the eight outputs are in a high impedance state.

All inputs are equipped with protection circuits against static discharge.

### Features

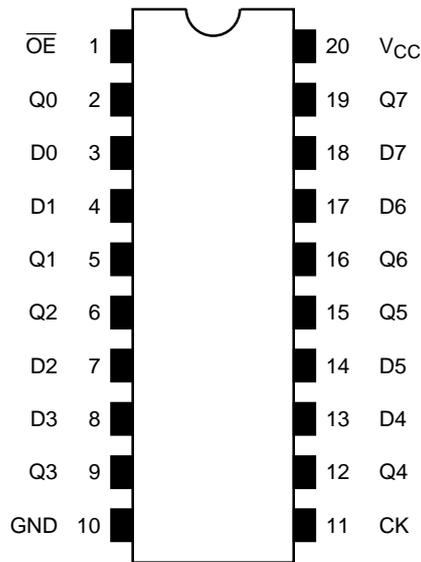
- Low-voltage operation:  $V_{CC} = 2.0$  to  $3.6$  V
- High-speed operation:  $t_{pd} = 8.5$  ns (max) ( $V_{CC} = 3.0$  to  $3.6$  V)
- Output current:  $|I_{OH}|/I_{OL} = 24$  mA (min) ( $V_{CC} = 3.0$  V)
- Latch-up performance:  $\pm 500$  mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- Power-down protection provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 374 type

Note: xxxFW (JEDEC SOP) is not available in Japan.

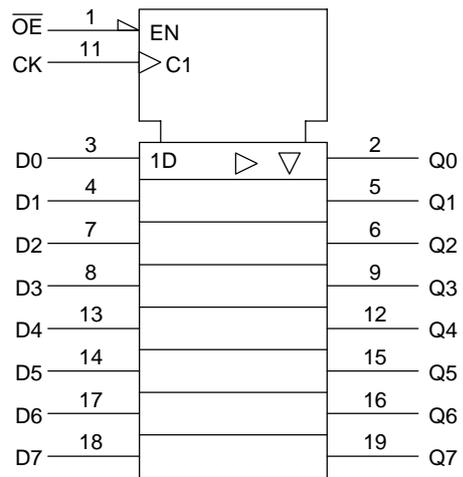


Weight  
 SOP20-P-300-1.27: 0.22 g (typ.)  
 SOL20-P-300-1.27: 0.46 g (typ.)  
 TSSOP20-P-0044-0.65: 0.08 g (typ.)

## Pin Assignment (top view)



## IEC Logic Symbol



## Truth Table

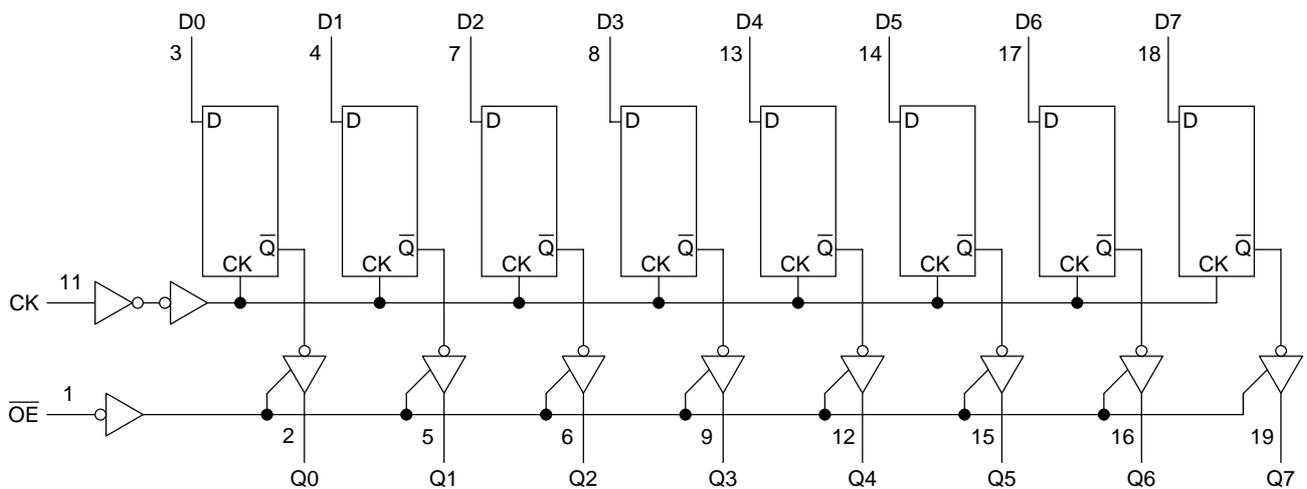
Inputs			Outputs
$\overline{OE}$	CK	D	
H	X	X	Z
L		X	Qn
L		L	L
L		H	H

X: Don't care

Z: High impedance

Qn: No change

## System Diagram



## Maximum Ratings

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5 to 7.0	V
DC input voltage	$V_{IN}$	-0.5 to 7.0	V
DC output voltage	$V_{OUT}$	-0.5 to 7.0 (Note 1)	V
		-0.5 to $V_{CC} + 0.5$ (Note 2)	
Input diode current	$I_{IK}$	-50	mA
Output diode current	$I_{OK}$	$\pm 50$ (Note 3)	mA
DC output current	$I_{OUT}$	$\pm 50$	mA
Power dissipation	$P_D$	180	mW
DC $V_{CC}$ /ground current	$I_{CC}/I_{GND}$	$\pm 100$	mA
Storage temperature	$T_{stg}$	-65 to 150	$^{\circ}C$

Note 1: Output in OFF state

Note 2: High or low state.  $I_{OUT}$  absolute maximum rating must be observed.

Note 3:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$

## Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	2.0 to 3.6	V
		1.5 to 3.6 (Note 4)	
Input voltage	$V_{IN}$	0 to 5.5	V
Output voltage	$V_{OUT}$	0 to 5.5 (Note 5)	V
		0 to $V_{CC}$ (Note 6)	
Output current	$I_{OH}/I_{OL}$	$\pm 24$ (Note 7)	mA
		$\pm 12$ (Note 8)	
Operating temperature	$T_{opr}$	-40 to 85	$^{\circ}C$
Input rise and fall time	$dt/dv$	0 to 10 (Note 9)	ns/V

Note 4: Data retention only

Note 5: Output in OFF state

Note 6: High or low state

Note 7:  $V_{CC} = 3.0$  to  $3.6$  V

Note 8:  $V_{CC} = 2.7$  to  $3.0$  V

Note 9:  $V_{IN} = 0.8$  to  $2.0$  V,  $V_{CC} = 3.0$  V

**Electrical Characteristics**

**DC Characteristics (Ta = -40 to 85°C)**

Characteristics		Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	—	2.7 to 3.6	2.0	—	V
	L-level	V <sub>IL</sub>	—	2.7 to 3.6	—	0.8	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2	V
				I <sub>OH</sub> = -12 mA	2.7	2.2	
				I <sub>OH</sub> = -18 mA	3.0	2.4	
				I <sub>OH</sub> = -24 mA	3.0	2.2	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.7 to 3.6	—	0.2
				I <sub>OL</sub> = 12 mA	2.7	—	0.4
				I <sub>OL</sub> = 16 mA	3.0	—	0.4
				I <sub>OL</sub> = 24 mA	3.0	—	0.55
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 5.5 V	2.7 to 3.6	—	±5.0	μA
3-state output OFF state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0 to 5.5 V	2.7 to 3.6	—	±5.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> /V <sub>OUT</sub> = 5.5 V	0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	2.7 to 3.6	—	10.0	μA
			V <sub>IN</sub> /V <sub>OUT</sub> = 3.6 to 5.5 V	2.7 to 3.6	—	±10.0	
Increase in I <sub>CC</sub> per input		ΔI <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> - 0.6 V	2.7 to 3.6	—	500	

**AC Characteristics (Ta = -40 to 85°C)**

Characteristics		Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Maximum clock frequency	f <sub>max</sub>	Figure 1, Figure 2	2.7	—	—	MHz	
			3.3 ± 0.3	150	—		
Propagation delay time (CK-Q)	t <sub>pLH</sub>	Figure 1, Figure 2	2.7	—	9.5	ns	
	t <sub>pHL</sub>		3.3 ± 0.3	1.5	8.5		
Output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	2.7	—	9.5	ns	
	t <sub>pZH</sub>		3.3 ± 0.3	1.5	8.5		
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	2.7	—	8.5	ns	
	t <sub>pHZ</sub>		3.3 ± 0.3	1.5	7.5		
Minimum pulse width (CK)	t <sub>w</sub> (H)	Figure 1, Figure 2	2.7	4.0	—	ns	
	t <sub>w</sub> (L)		3.3 ± 0.3	3.3	—		
Minimum setup time	t <sub>s</sub>	Figure 1, Figure 2	2.7	2.5	—	ns	
			3.3 ± 0.3	2.5	—		
Minimum hold time	t <sub>h</sub>	Figure 1, Figure 2	2.7	1.5	—	ns	
			3.3 ± 0.3	1.5	—		
Output to output skew	t <sub>osLH</sub>	(Note 10)	2.7	—	—	ns	
	t <sub>osHL</sub>		3.3 ± 0.3	—	1.0		

Note 10: Parameter guaranteed by design.

$$(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$$

**Dynamic Switching Characteristics**

( $T_a = 25^\circ\text{C}$ , input:  $t_r = t_f = 2.5 \text{ ns}$ ,  $C_L = 50 \text{ pF}$ ,  $R_L = 500 \Omega$ )

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Typ.	Unit
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	3.3	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	3.3	0.8	V

**Capacitive Characteristics ( $T_a = 25^\circ\text{C}$ )**

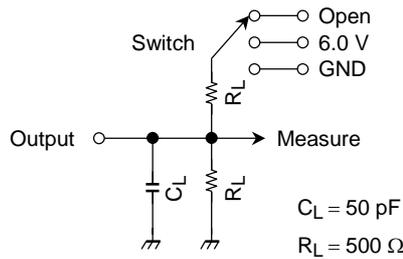
Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Typ.	Unit
Input capacitance	C <sub>IN</sub>	—	3.3	7	pF
Output capacitance	C <sub>OUT</sub>	—	3.3	8	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz (Note 11)	3.3	25	pF

Note 11: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$$

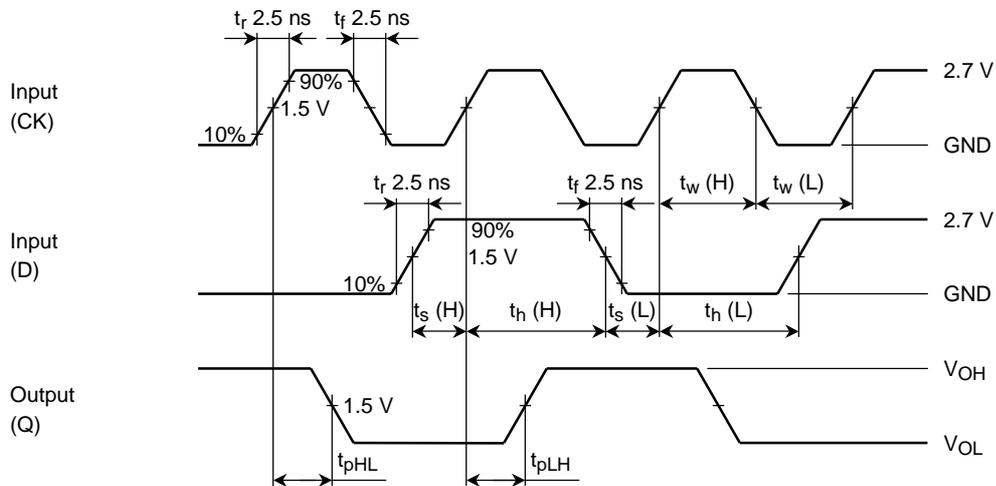
**AC Test Circuit**



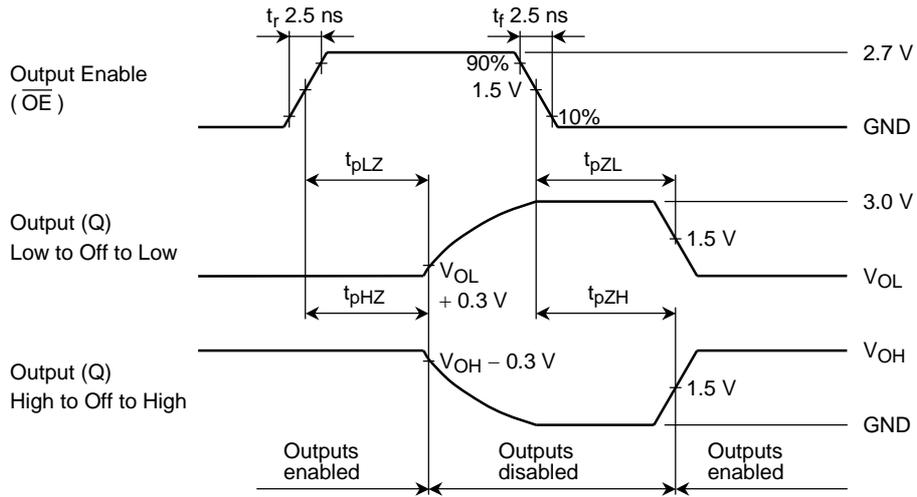
Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	6.0 V
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND
t <sub>w</sub> , t <sub>s</sub> , t <sub>h</sub> , t <sub>max</sub>	Open

**Figure 1**

**AC Waveform**



**Figure 2** t<sub>pLH</sub>, t<sub>pHL</sub>, t<sub>w</sub>, t<sub>s</sub>, t<sub>h</sub>

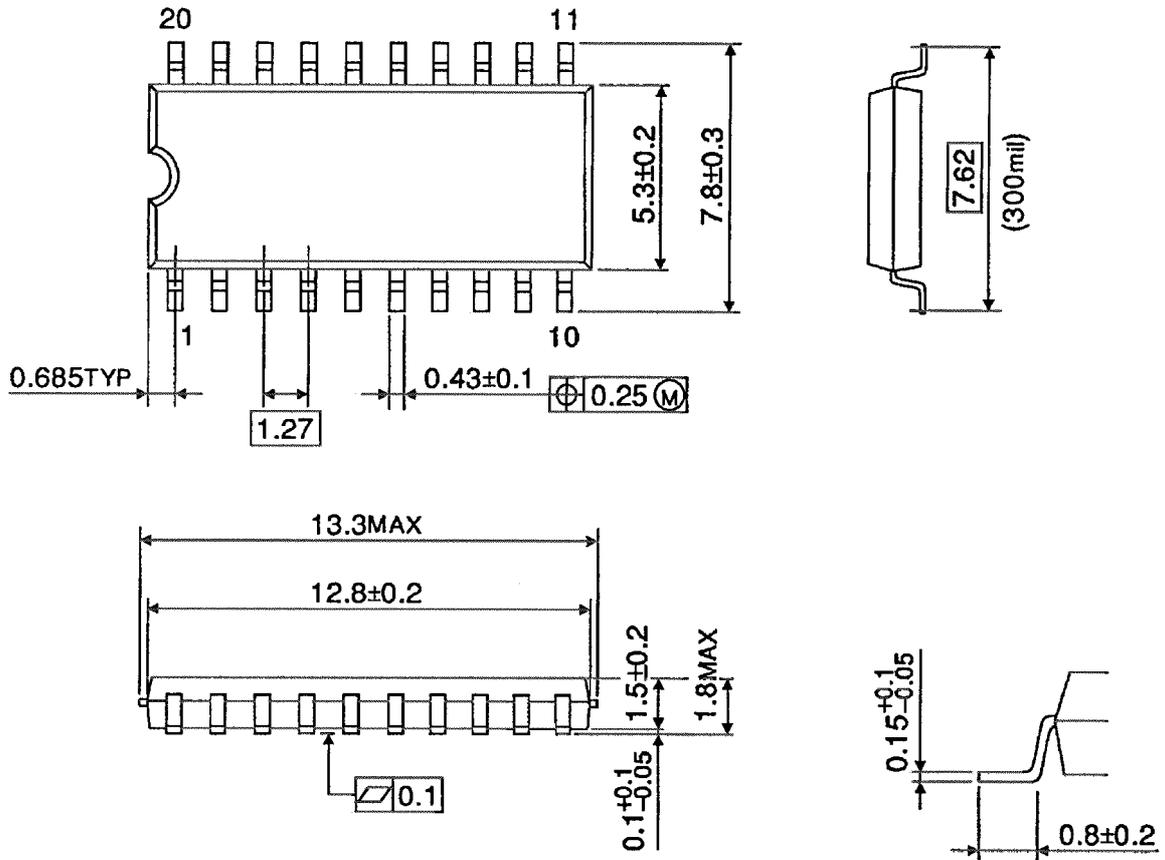


**Figure 3**  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$

**Package Dimensions**

SOP20-P-300-1.27

Unit : mm



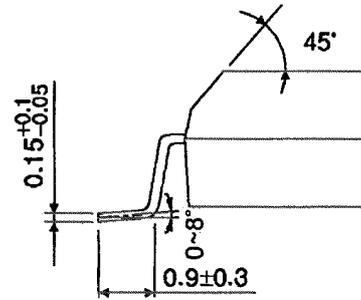
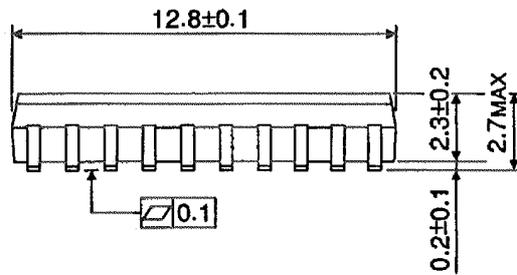
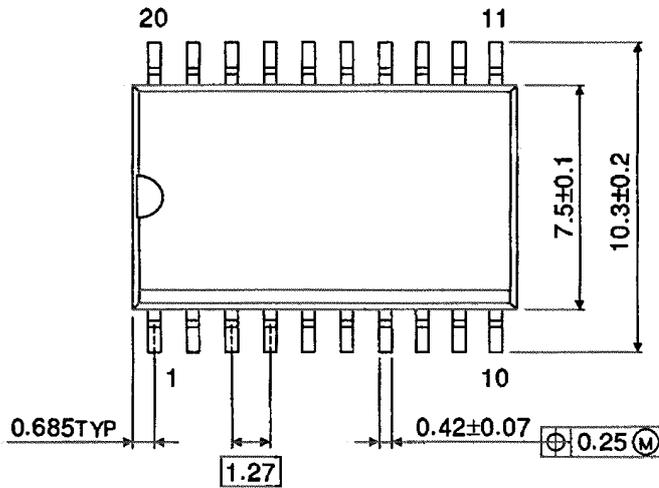
Weight: 0.22 g (typ.)

## Package Dimensions

SOL20-P-300-1.27

Unit : mm

Note: This package is not available in japan.

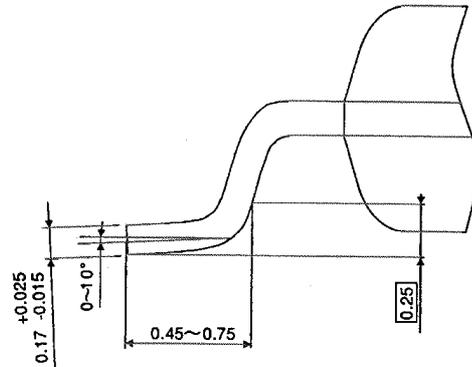
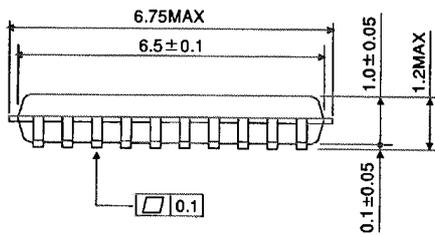
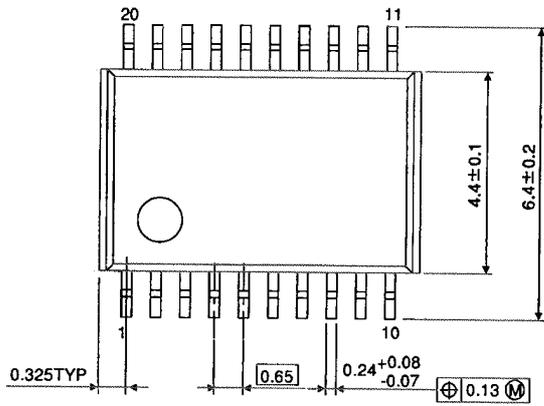


Weight: 0.46 g (typ.)

**Package Dimensions**

TSSOP20-P-0044-0.65

Unit : mm



Weight: 0.08 g (typ.)

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